

**Notice of References Cited**Application/Control No.  
**09/621,400**Applicant(s)/Patent Under Reexam  
**Alameda et al.**Examiner  
**Te Chen**Art Unit  
**2171**

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**U.S. PATENT DOCUMENTS**

	<b>Document Number</b> Country Code-Number-Kind Code	<b>Date</b> MM-YYYY <sup>1</sup>	<b>Name</b>	<b>Classification</b> <sup>2</sup>	
A	6,108,420	8/2000	Larose et al.	380	4
B	6,067,582	5/2000	Smith et al.	710	5
C	6,006,035	12/1999	Nabahi	395	712
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**NON-PATENT DOCUMENTS**

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<sup>1</sup> Dates in MM-YYYY format are publication dates.<sup>2</sup> Classifications may be U.S. or foreign.